# imall

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## **Power MOSFET** 40 V, 10 m $\Omega$ , 53 A, Dual N–Channel, Dual SO–8FL

#### Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5853NWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb-Free and Halogen-Free Device

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

	,				
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-	Steady State	$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	53	А
rent R <sub>θJC</sub> (Notes 1, 2, 3)		T <sub>C</sub> = 100°C		37	
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	58	W
R <sub>θJC</sub> (Notes 1, 2)		$T_{C} = 100^{\circ}C$		29	
Continuous Drain Cur-	Steady State	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	12	А
rent R <sub>θJA</sub> (Notes 1, 2 & 3)		T <sub>A</sub> = 100°C		8.7	
Power Dissipation		T <sub>A</sub> = 25°C	PD	3.1	W
$R_{\theta JA}$ (Notes 1 & 2)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		I <sub>DM</sub>	165	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	53	А
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $I_{L(pk)}$ = 28.3 A, L = 0.1 mH)			E <sub>AS</sub>	40	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	2.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

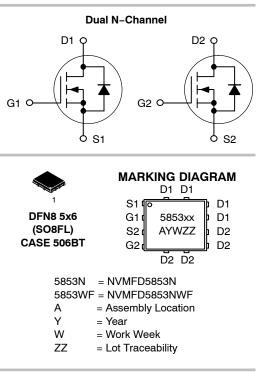
3. Continuous DC current rating. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.



### **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
40 V	10 mΩ @ 10 V	53 A



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVMFD5853NT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5853NWFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

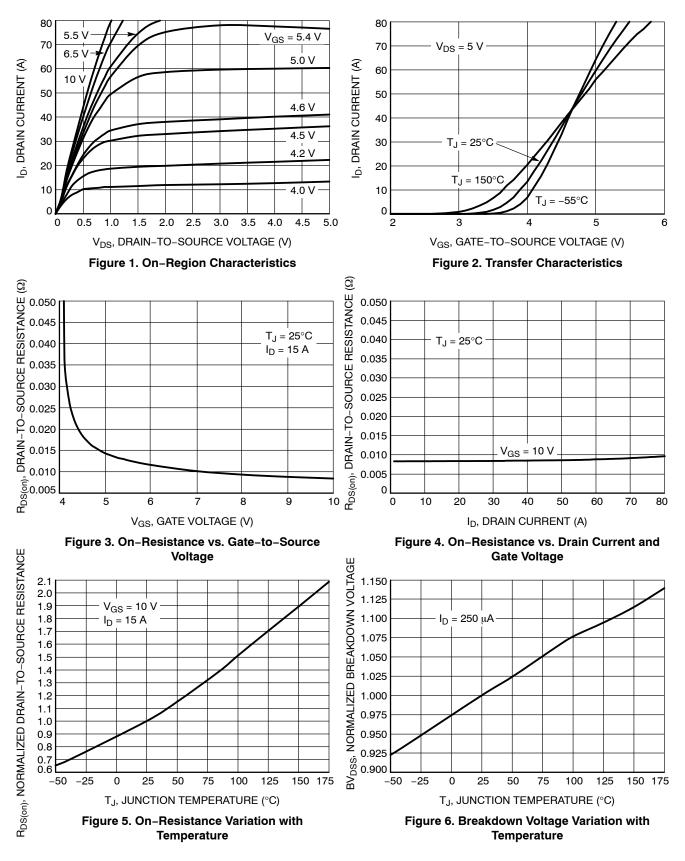
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Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				41.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 40 V$	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A			8.4	10	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 15 A			44		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			1225		pF
Output Capacitance	C <sub>oss</sub>				150		_
Reverse Transfer Capacitance	C <sub>rss</sub>				100		
Total Gate Charge	Q <sub>G(TOT)</sub>				24		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 15 A			1.5		1
Gate-to-Source Charge	Q <sub>GS</sub>				5.2		
Gate-to-Drain Charge	Q <sub>GD</sub>				6.6		
Plateau Voltage	V <sub>GP</sub>				4.1		V
SWITCHING CHARACTERISTICS (No	ote 5)						
Turn-On Delay Time	t <sub>d(on)</sub>				9		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 2.5 Ω			20		<sup>ا</sup> [
Turn-Off Delay Time	t <sub>d(off)</sub>				21		
Fall Time	t <sub>f</sub>				3		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage V <sub>SD</sub>	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.82	1.1	V
	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 15 A	T <sub>J</sub> = 125°C		0.72			
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, d <sub>IS</sub> /d <sub>t</sub> = 100 A/µs, I <sub>S</sub> = 15 A			16		ns
Charge Time	t <sub>a</sub>				10		
Discharge Time	t <sub>b</sub>				6		
Reverse Recovery Charge	Q <sub>RR</sub>				9		nC

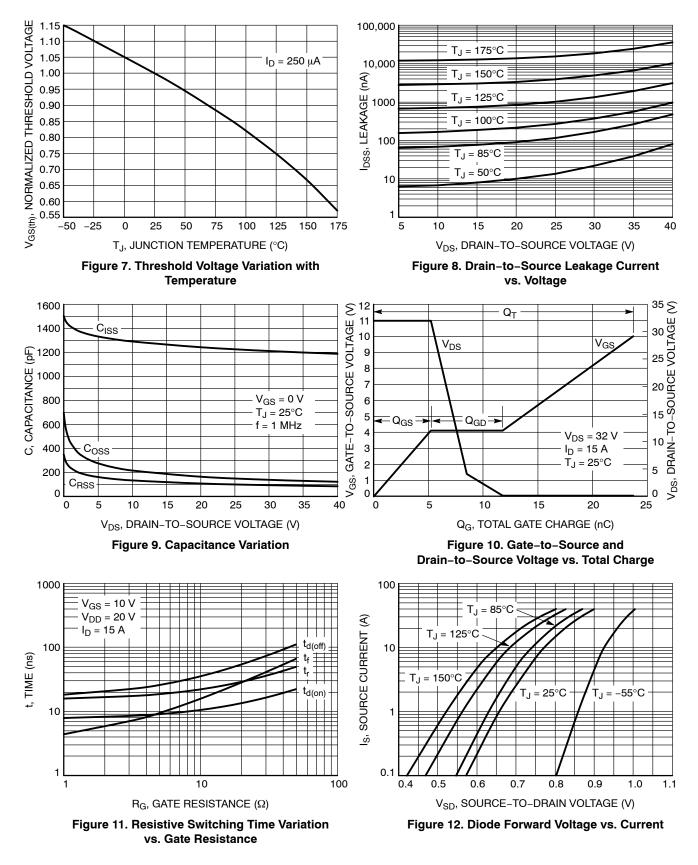
#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

 $\begin{array}{ll} \mbox{4. Pulse Test: pulse width = 300 $\mu$s, duty cycle $\le 2\%$.} \\ \mbox{5. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

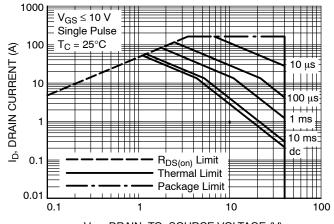
#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**



V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 13. Maximum Rated Forward Biased Safe Operating Area

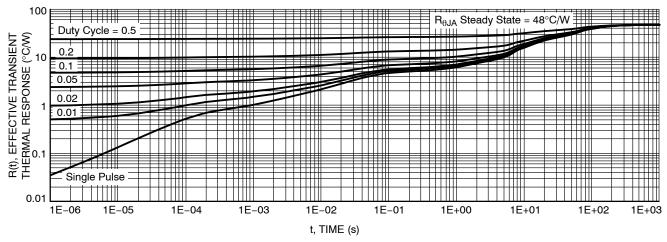
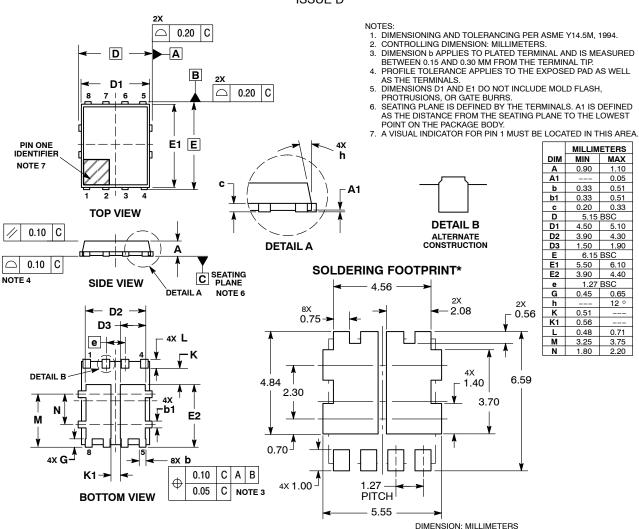


Figure 14. Thermal Impedance (Junction-to-Ambient)

#### PACKAGE DIMENSIONS

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual) CASE 506BT ISSUE D



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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